	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
ΔV _{(BR)DSS} /ΔTJ	Breakdown Voltage Temp. Coefficient		0.035		V/°C	Reference to 25°C, I _D = 1mA [®]
R _{DS(on)}	Static Drain-to-Source On-Resistance		—	0.008	Ω	V _{GS} = 10V, I _D = 31A ④
			—	0.010		V _{GS} = 5.0V, I _D = 31A ④
			—	0.013		V _{GS} = 4.0V, I _D = 26A ④
V _{GS(th)}	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
g fs	Forward Transconductance	59			S	V _{DS} = 25V, I _D = 54A ©
I _{DSS}	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$
				250		V _{DS} = 44V, V _{GS} = 0V, T _J = 150°C
	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V
GSS	Gate-to-Source Reverse Leakage			-100		V _{GS} = -16V
Qg	Total Gate Charge			130		I _D = 54A
Q _{gs}	Gate-to-Source Charge			25	nC	V _{DS} = 44V
Q _{gd}	Gate-to-Drain ("Miller") Charge			67		V _{GS} = 5.0V, See Fig. 6 and 13 🖲
t _{d(on)}	Turn-On Delay Time		12			V _{DD} = 28V
t _r	Rise Time		160		ns	I _D = 54A
t _{d(off)}	Turn-Off Delay Time		43		115	R_{G} = 1.3 Ω , V_{GS} = 5.0V
t _f	Fall Time		84			R _D = 0.50Ω, See Fig. 10 ④ ⑤
L _D	Internal Drain Inductance		4.5	_	nH	Between lead,
						6mm (0.25in.)
L _S	Internal Source Inductance		7.5			from package
						and center of die contact
Ciss	Input Capacitance		5000			V _{GS} = 0V
Coss	Output Capacitance		1100		pF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		390			f = 1.0MHz, See Fig. 5®
С	Drain to Sink Capacitance		12			f = 1.0MHz

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
ls	Continuous Source Current		_	58	Α	MOSFET symbol	
	(Body Diode)					showing the	
Ism	Pulsed Source Current			360		integral reverse 🔍 🗍	
	(Body Diode) ①					p-n junction diode.	
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C, I _S = 31A, V _{GS} = 0V ④	
trr	Reverse Recovery Time		140	210	ns	T _J = 25°C, I _F = 54A	
Qrr	Reverse RecoveryCharge		650	970	nC	di/dt = 100A/µs	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\rm S}\text{+}L_{\rm D})$					

Notes:

 $\label{eq:static} \begin{array}{l} \textcircled{\sc line 0} \end{array} \mbox{ Repetitive rating; pulse width limited by } \\ max. junction temperature. (See fig. 11) \\ \textcircled{\sc line 0} V_{DD} = 25V, \mbox{ starting } T_J = 25^\circ C, \mbox{ L} = 240 \mu H \\ R_G = 25\Omega, \mbox{ I}_{AS} = 54A. \mbox{ (See Figure 12)} \end{array}$

 $I_{SD} \le 54A$, di/dt $\le 230A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, t=60s, f=60Hz $T_J \le 175^{\circ}C$

 $\textcircled{Pulse width \leq 300 \mu s; duty cycle \leq 2\%.}$ B Use IRL2505 data and test conditions

International **tor** Rectifier

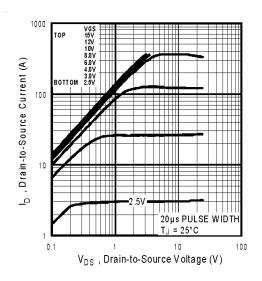


Fig 1. Typical Output Characteristics

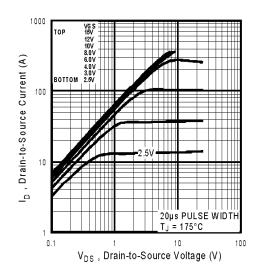


Fig 2. Typical Output Characteristics

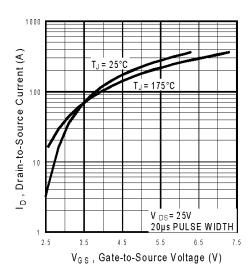


Fig 3. Typical Transfer Characteristics

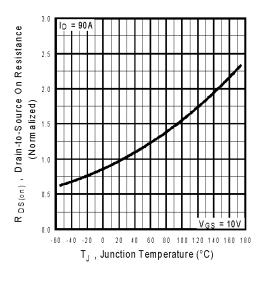
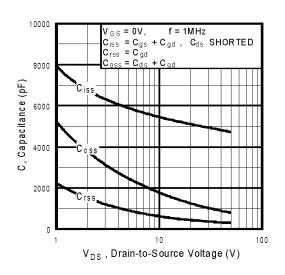
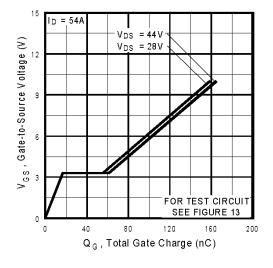


Fig 4. Normalized On-Resistance Vs. Temperature

International









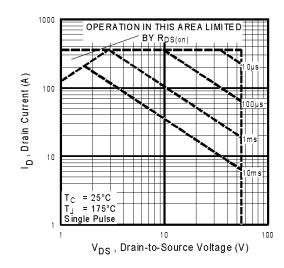
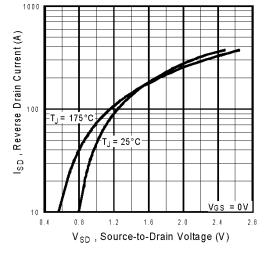
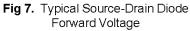


Fig 8. Maximum Safe Operating Area

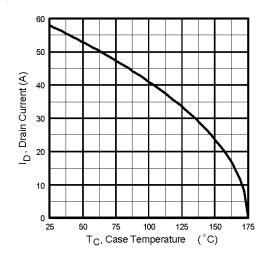
www.irf.com

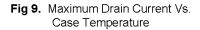




4







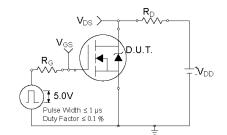


Fig 10a. Switching Time Test Circuit

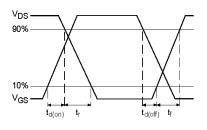


Fig 10b. Switching Time Waveforms

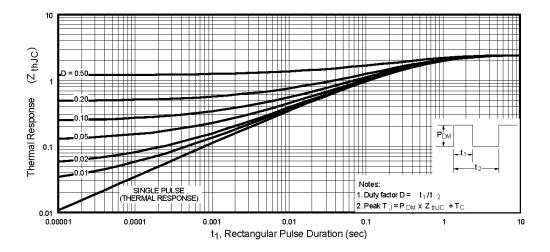


Fig 11. Maximum Effective I ransient I hermal Impedance, Junction-to-Case

International **tor** Rectifier

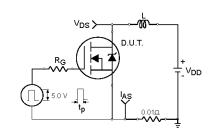


Fig 12a. Unclamped Inductive Test Circuit

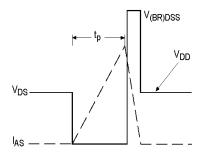


Fig 12b. Unclamped Inductive Waveforms

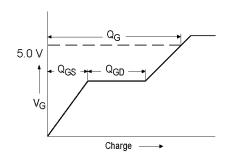


Fig 13a. Basic Gate Charge Waveform

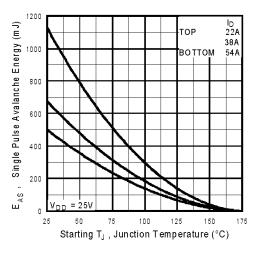


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

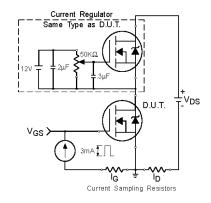
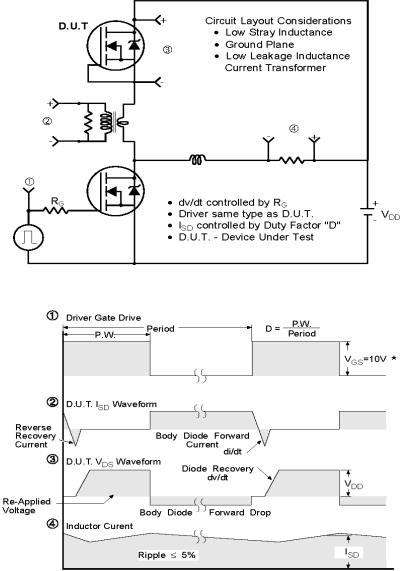


Fig 13b. Gate Charge Test Circuit

International **ISPR** Rectifier

Peak Diode Recovery dv/dt Test Circuit

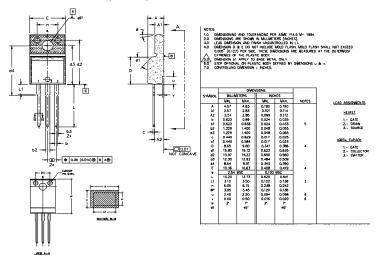


* V_{GS} = 5V for Logic Level Devices

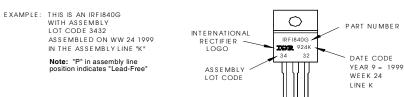
Fig 14. For N-Channel HEXFETS

TO-220 Full-Pak Package Outline

Dimensions are shown in millimeters (inches)



TO-220 Full-Pak Part Marking Information



Data and specifications subject to change without notice.

International **ICR** Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information.06/04 8 www.irf.com Note: For the most current drawings please refer to the IR website at: <u>http://www.irf.com/package/</u>